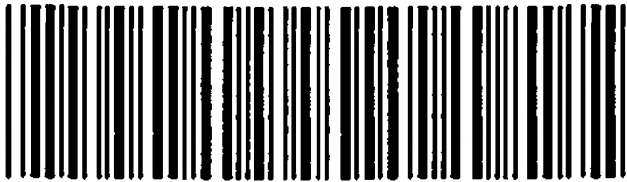


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/614,960	CHEN, SHUN-MIN	
	Examiner	Art Unit	
	Frank Vanaman	3618	

SEARCHED			
Class	Subclass	Date	Examiner
280	642, 644, 647, 648, 650, 657,	7/6/2005	FBV
280	658, 47.4	7/6/2005	FBV
280	47.38	7/6/2005	FBV
297	354.1	7/6/2005	FBV
297	354.12	7/6/2005	FBV
297	363	7/6/2005	FBV
297	Dig. 4	7/6/2005	FBV
188	19, 20	7/6/2005	FBV

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR